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Affiliation

Universidad Autonoma de Madrid, Spain

Publication Topics

Face Recognition, Average Accuracy, Data Augmentation, Equal Error Rate, Face Images, Loss Function, Random Flipping, Accuracy Verification, Baseline System, Challenges In The Era, Challenging Conditions, Facial Recognition Technology, Generative Adversarial Networks, Intra-class Variance, Presence Of Occlusion, Real Database, Recurrent Neural Network, Standard Deviation Of Accuracy, Stochastic Gradient Descent, Synthetic Images, Training Dataset, Acquisition Session, Adam Optimizer, Almost Complete, Application Of Data, Application Programming Interface, Assistant Role, Attention Mechanism, Attention Module, Benchmark, Benchmark Datasets, Biometric Systems, Caucasian Group, Chatbot, Competition Law, Complete Freedom, Confidence Value, Considerable Performance Improvement, Convolutional Neural Network, Data Augmentation Techniques, Decision Scenarios, Deep Embedding, Deep Learning, Domain Adaptation, Ethnic Groups, Extreme Conditions

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Biography

Ivan Deandres-Tame received the B.Sc. in Computer Science and Engineering in 2021 and the M.Sc. in Deep learning for Image, Audio and Video processing in 2022 from the Universidad Autonoma de Madrid. In May 2023, he joined the Biometrics and Data Pattern Analytics Lab - BiDA Lab (UAM), where he is currently collaborating as an assistant researcher pursuing a Ph.D. degree. The research activities he is currently working on include Human-Computer interaction for Digital Health and Digital Security domain, Face Recognition, Machine Learning, and Deep Learning. (Based on document published on 26 February 2024).

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Co-Authors:

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SDFR: Synthetic Data for Face Recognition Competition

Hatef Otroschi Shahreza; Christophe Ecabert; Anjith George; Alexander Unnervik; Sébastien Marcel; Nicolò Di Domenico; Guido Borghi; Davide Maltoni; Fadi Boutros; Julia Vogel; Naser Damer; Ángela Sánchez-Pérez; Enrique Mas-Candela; Jorge Calvo-Zaragoza; Bernardo Biesseck; Pedro Vidal; Roger Granada; David Menotti; Ivan DeAndres-Tame; Simone Maurizio La Cava; Sara Concas; Pietro Melzi; Ruben Tolosana; Ruben Vera-Rodriguez; Gianpaolo Perelli; Giulia Orrù; Gian Luca Marcialis; Julian Fierrez

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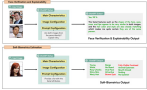


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How Good Is ChatGPT at Face Biometrics? A First Look Into Recognition, Soft Biometrics, and Explainability



Ivan Deandres-Tame; Ruben Tolosana; Ruben Vera-Rodriguez;
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